



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts,Customers Priority,Honest Operation,and Considerate Service",our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





# Si823x Data Sheet

## 0.5 and 4.0 Amp ISOdrivers (2.5 and 5 kV<sub>RMS</sub>)

The Si823x isolated driver family combines two independent, isolated drivers into a single package. The Si8230/1/3/4 are high-side/low-side drivers, while the Si8232/5/7/8 are dual drivers. Versions with peak output currents of 0.5 A (Si8230/1/2/7) and 4.0 A (Si8233/4/5/8) are available. All drivers operate with a maximum supply voltage of 24 V.

The Si823x drivers utilize Silicon Labs' proprietary silicon isolation technology, which provides up to 5 kV<sub>RMS</sub> withstand voltage per UL1577 and fast 45 ns propagation times. Driver outputs can be grounded to the same or separate grounds or connected to a positive or negative voltage. The TTL level compatible inputs with >400 mV hysteresis are available in individual control input (Si8230/2/3/5/7/8) or PWM input (Si8231/4) configurations. High integration, low propagation delay, small installed size, flexibility, and cost-effectiveness make the Si823x family ideal for a wide range of isolated MOSFET/IGBT gate drive applications.

### Applications

- Power delivery systems
- Motor control systems
- Isolated dc-dc power supplies
- Lighting control systems
- Plasma displays
- Solar and industrial inverters

### Safety Approval

- UL 1577 recognized
  - Up to 5000 V<sub>RMS</sub> for 1 minute
- CSA component notice 5A approval
  - IEC 60950-1, 62368-1, 60601-1 (reinforced insulation)
- VDE certification conformity
  - VDE 0884-10 Basic Insulation
  - EN 60950-1 Reinforced Insulation
- CQC certification approval
  - GB4943.1

### KEY FEATURES

- Two completely isolated drivers in one package
  - Up to 5 kV<sub>RMS</sub> input-to-output isolation
  - Up to 1500 V<sub>DC</sub> peak driver-to-driver differential voltage
- HS/LS and dual driver versions
- Up to 8 MHz switching frequency
- 0.5 A peak output (Si8230/1/2/7)
- 4.0 A peak output (Si8233/4/5/8)
- High electromagnetic immunity
- RoHS-compliant packages:
  - SOIC-14/16 wide body
  - SOIC-16 narrow body
  - LGA-14
  - QFN-14 (pin to pin compatible with LGA-14 packages)

## 1. Feature List

The Si823x highlighted features are listed below.

- Two completely isolated drivers in one package:
  - Up to 5 kV<sub>RMS</sub> input-to-output isolation
  - Up to 1500 V<sub>DC</sub> peak driver-to-driver differential voltage
- HS/LS and dual driver versions
- Up to 8 MHz switching frequency
- 0.5 A peak output (Si8230/1/2/7)
- 4.0 A peak output (Si8233/4/5/8)
- High electromagnetic immunity
- 45 ns propagation delay (max)
- Independent HS and LS inputs or PWM input versions
- Overlap protection and programmable dead time
- AEC-Q100 qualification
- Wide operating range:
  - –40 to +125 °C
- RoHS-compliant packages:
  - SOIC-14/16 wide body
  - SOIC-16 narrow body
  - LGA-14
  - QFN-14 (pin to pin compatible with LGA-14 packages)

## 2. Ordering Guide

Table 2.1. Si823x Ordering Guide 1, 2, 3

Ordering Part Number (OPN)	Inputs	Configuration	Peak Current	UVLO Voltage	Isolation Rating	Temp Range	Package Type	Legacy Ordering Part Number (OPN) 2.5 kV Only
<b>Wide Body (WB) Package Options</b>								
Si8230BB-D-IS	VIA, VIB	High Side/ Low Side	0.5 A	8 V	2.5 kVrms	-40 to +125 °C	SOIC-16 Wide Body	Si8230-A-IS
Si8231BB-D-IS	PWM	High Side/ Low Side						Si8231-A-IS
Si8232BB-D-IS	VIA, VIB	Dual Driver						Si8232-A-IS
Si8234CB-D-IS	PWM	High Side/ Low Side	4.0 A	10 V	2.5 kVrms	-40 to +125 °C	SOIC-16 Wide Body	N/A
Si8233BB-D-IS	VIA, VIB	High Side/ Low Side		8 V				Si8233-B-IS
Si8234BB-D-IS	PWM	High Side/ Low Side						Si8234-B-IS
Si8235BB-D-IS	VIA, VIB	Dual Driver		Si8235-B-IS				
Si8230AB-D-IS	VIA, VIB	High Side/ Low Side	0.5 A	5 V	2.5 kVrms	-40 to +125 °C	SOIC-16 Wide Body	N/A
Si8231AB-D-IS	PWM							N/A
Si8232AB-D-IS	VIA, VIB							Dual Driver
Si8233AB-D-IS	VIA, VIB	High Side/ Low Side	4.0 A	5 V	2.5 kVrms	-40 to +125 °C	SOIC-16 Wide Body	N/A
Si8234AB-D-IS	PWM							N/A
Si8235AB-D-IS	VIA, VIB	Dual Driver	N/A					
<b>Narrow Body (NB) Package Options</b>								
Si8230BB-D-IS1	VIA, VIB	High Side/ Low Side	0.5 A	8 V	2.5 kVrms	-40 to +125 °C	SOIC-16 Narrow Body	N/A
Si8231BB-D-IS1	PWM	High Side/ Low Side						
Si8232BB-D-IS1	VIA, VIB	Dual Driver						
Si8233BB-D-IS1	VIA, VIB	High Side/ Low Side	4.0 A	8 V	1.0 kVrms			
Si8234BB-D-IS1	PWM	High Side/ Low Side						
Si8235BB-D-IS1	VIA, VIB	Dual Driver						
Si8235BA-D-IS1	VIA, VIB	Dual Driver						

Ordering Part Number (OPN)	Inputs	Configuration	Peak Current	UVLO Voltage	Isolation Rating	Temp Range	Package Type	Legacy Ordering Part Number (OPN) 2.5 kV Only
Si8230AB-D-IS1	VIA, VIB	High Side/ Low Side	0.5 A	5 V	2.5 kVrms	-40 to +125 °C	SOIC-16 Narrow Body	N/A
Si8231AB-D-IS1	PWM							N/A
Si8232AB-D-IS1	VIA, VIB	Dual Driver	4.0 A	5 V				N/A
Si8233AB-D-IS1	VIA, VIB	High Side/ Low Side						N/A
Si8234AB-D-IS1	PWM							N/A
Si8235AB-D-IS1	VIA, VIB	Dual Driver						N/A
<b>LGA Package Options</b>								
Si8233CB-D-IM	VIA, VIB	High Side/ Low Side	4.0 A	10 V	2.5 kVrms	-40 to +125 °C	LGA-14 5x5 mm	N/A
Si8233BB-D-IM				8 V				Si8233-B-IM
Si8233AB-D-IM				5 V				N/A
Si8234BB-D-IM	PWM			8 V				Si8234-B-IM
Si8234AB-D-IM				5 V				N/A
Si8235BB-D-IM	VIA, VIB	Dual Driver	8 V	Si8235-B-IM				
Si8235AB-D-IM			5 V	N/A				
<b>QFN Package Options</b>								
Si8233AB-D-IM1	VIA, VIB	High Side/ Low Side	4.0 A	5 V	2.5 kVrms	-40 to +125 °C	QFN-14	N/A
Si8233BB-D-IM1				8 V				N/A
Si8234AB-D-IM1	PWM			5 V				N/A
Si8234BB-D-IM1				8 V				N/A
Si8235AB-D-IM1	VIA, VIB	Dual Driver	5 V	N/A				
Si8235BB-D-IM1			8 V	N/A				
<b>5 kV Ordering Options</b>								
Si8230BD-D-IS	VIA, VIB	High Side/ Low Side	0.5 A	8 V	5.0 kVrms	-40 to +125 °C	SOIC-16 Wide Body	N/A
Si8231BD-D-IS	PWM	High Side/ Low Side						
Si8232BD-D-IS	VIA, VIB	Dual Driver						
Si8233BD-D-IS	VIA, VIB	High Side/ Low Side	4.0 A					
Si8234BD-D-IS	PWM	High Side/ Low Side						
Si8235BD-D-IS	VIA, VIB	Dual Driver						

Ordering Part Number (OPN)	Inputs	Configuration	Peak Current	UVLO Voltage	Isolation Rating	Temp Range	Package Type	Legacy Ordering Part Number (OPN) 2.5 kV Only		
Si8230AD-D-IS	VIA, VIB	High Side/ Low Side	0.5 A	5 V	5.0 kVrms	-40 to +125 °C	SOIC-16 Wide Body	N/A		
Si8231AD-D-IS	PWM							N/A		
Si8232AD-D-IS	VIA, VIB	Dual Driver	N/A							
Si8233AD-D-IS	VIA, VIB	High Side/ Low Side	4.0 A	5 V				N/A		
Si8234AD-D-IS	PWM							N/A		
Si8235AD-D-IS	VIA, VIB	Dual Driver						N/A		
SI8230AD-D-IS3	VIA, VIB	High Side/ Low Side					0.5 A	8 V	SOIC-14 Wide Body with increased creepage	N/A
SI8230BD-D-IS3	VIA, VIB						N/A			
SI8233AD-D-IS3	VIA, VIB						4.0 A	5 V		N/A
SI8233BD-D-IS3	VIA, VIB		8 V	N/A						
SI8235AD-D-IS3	VIA, VIB		Dual Driver	5 V			N/A			
SI8235BD-D-IS3	VIA, VIB			8 V			N/A			

Ordering Part Number (OPN)	Inputs	Configuration	Peak Current	UVLO Voltage	Isolation Rating	Temp Range	Package Type	Legacy Ordering Part Number (OPN) 2.5 kV Only
----------------------------	--------	---------------	--------------	--------------	------------------	------------	--------------	---

**3 V VDDI Ordering Options**

Si8237AB-D-IS1	VIA, VIB	Dual Driver	0.5 A	5 V	2.5 kVrms	-40 to +125 °C	SOIC-16 Narrow Body	N/A	
Si8237BB-D-IS1	VIA, VIB	Dual Driver		8 V					
Si8238AB-D-IS1	VIA, VIB	Dual Driver	4.0 A	5 V					
Si8238BB-D-IS1	VIA, VIB	Dual Driver		8 V					
Si8237AD-D-IS	VIA, VIB	Dual Driver	0.5 A	5 V	5.0 kVrms		SOIC-16 Wide Body		
Si8237BD-D-IS	VIA, VIB	Dual Driver		8 V					
Si8238AD-D-IS	VIA, VIB	Dual Driver	4.0 A	5 V					SOIC-14 Wide Body with increased creepage
Si8238BD-D-IS	VIA, VIB	Dual Driver		8 V					
SI8238AD-D-IS3	VIA, VIB	Dual Driver		5 V					
SI8238BD-D-IS3	VIA, VIB	Dual Driver		8 V					

1. All packages are RoHS-compliant with peak reflow temperatures of 260 °C according to the JEDEC industry standard classifications and peak solder temperatures.
2. "Si" and "SI" are used interchangeably.
3. An "R" at the end of the part number denotes tape and reel packaging option.

# Table of Contents

<b>1. Feature List</b>	<b>2</b>
<b>2. Ordering Guide</b>	<b>3</b>
<b>3. System Overview</b>	<b>8</b>
3.1 Top Level Block Diagrams	8
3.2 Functional Description	10
3.3 Typical Operating Characteristics (0.5 Amp)	11
3.4 Typical Operating Characteristics (4.0 Amp)	14
3.5 Family Overview and Logic Operation During Startup	16
3.5.1 Products	16
3.5.2 Device Behavior	17
3.6 Power Supply Connections	18
3.7 Power Dissipation Considerations	19
3.8 Layout Considerations	20
3.9 Undervoltage Lockout Operation	21
3.9.1 Device Startup	21
3.9.2 Undervoltage Lockout	21
3.9.3 Undervoltage Lockout (UVLO)	21
3.9.4 Control Inputs	22
3.9.5 Disable Input	22
3.10 Programmable Dead Time and Overlap Protection	23
<b>4. Electrical Specifications</b>	<b>25</b>
4.1 Test Circuits	28
<b>5. Applications</b>	<b>34</b>
5.1 High-Side/Low-Side Driver	34
5.2 Dual Driver	35
<b>6. Pin Descriptions</b>	<b>36</b>
<b>7. Package Outlines</b>	<b>42</b>
7.1 Package Outline: 16-Pin Wide Body SOIC	42
7.2 Package Outline: 14-Pin Wide Body SOIC	44
7.3 Package Outline: 16-Pin Narrow Body SOIC	46
7.4 Package Outline: 14 LD LGA (5 x 5 mm)	47
7.5 Package Outline: 14 LD QFN	48
<b>8. Land Patterns</b>	<b>49</b>
8.1 Land Pattern: 16-Pin Wide Body SOIC	49
8.2 Land Pattern: 14-Pin Wide Body SOIC	50
8.3 Land Pattern: 16-Pin Narrow Body SOIC	51

8.4 Land Pattern: 14 LD LGA/QFN . . . . .	.52
<b>9. Top Markings . . . . .</b>	<b>53</b>
9.1 Si823x Top Marking (14/16-Pin Wide Body SOIC). . . . .	.53
9.2 Si823x Top Marking (16-Pin Narrow Body SOIC) . . . . .	.54
9.3 Si823x Top Marking (14 LD LGA/QFN) . . . . .	.55
<b>10. Revision History. . . . .</b>	<b>56</b>



### 3. System Overview

#### 3.1 Top Level Block Diagrams

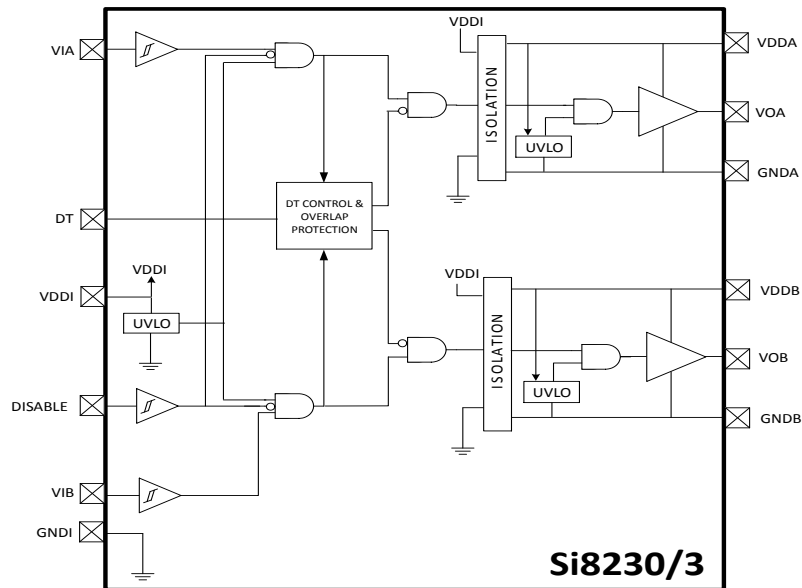


Figure 3.1. Si8230/3 Two-Input High-Side/Low-Side Isolated Drivers

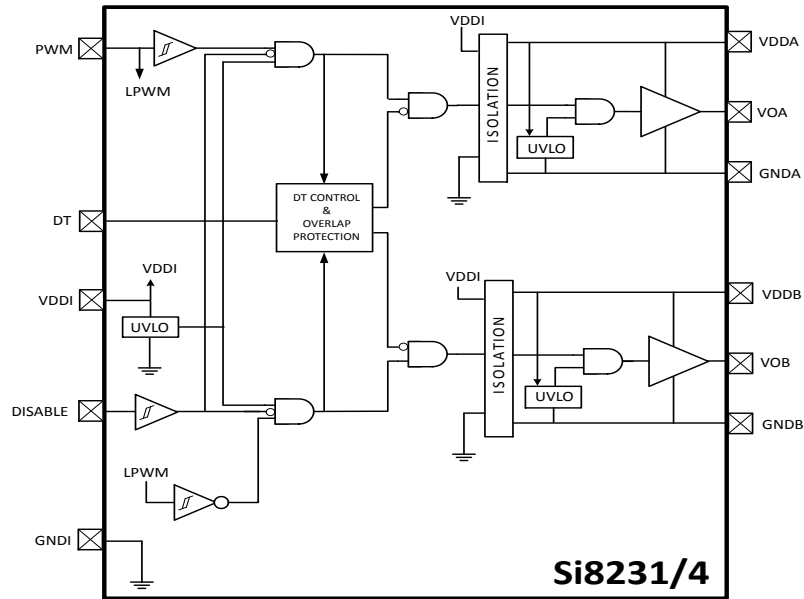


Figure 3.2. Si8231/4 Single-Input High-Side/Low-Side Isolated Drivers

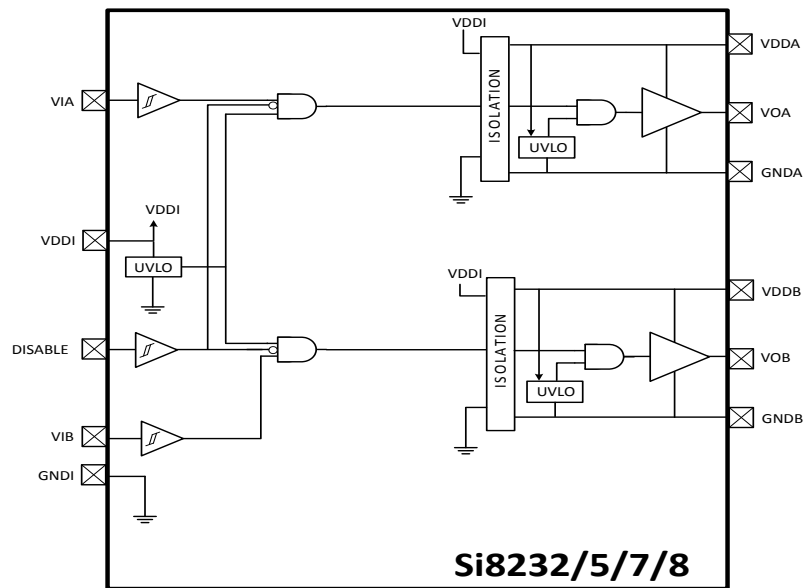


Figure 3.3. Si8232/5/7/8 Dual Isolated Drivers

### 3.2 Functional Description

The operation of an Si823x channel is analogous to that of an optocoupler and gate driver, except an RF carrier is modulated instead of light. This simple architecture provides a robust isolated data path and requires no special considerations or initialization at start-up. A simplified block diagram for a single Si823x channel is shown in the figure below.

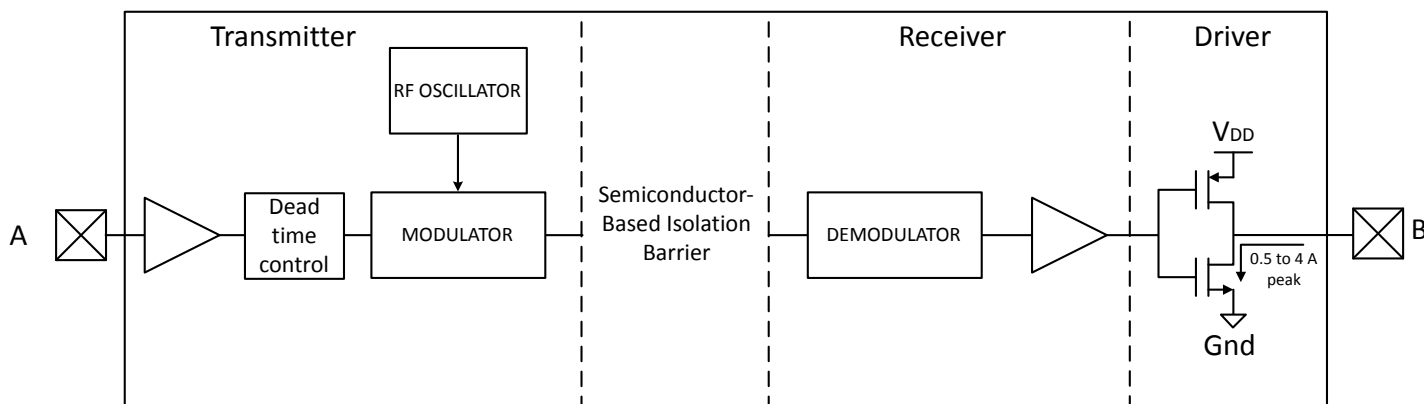


Figure 3.4. Simplified Channel Diagram

A channel consists of an RF Transmitter and RF Receiver separated by a semiconductor-based isolation barrier. Referring to the Transmitter, input A modulates the carrier provided by an RF oscillator using on/off keying. The Receiver contains a demodulator that decodes the input state according to its RF energy content and applies the result to output B via the output driver. This RF on/off keying scheme is superior to pulse code schemes as it provides best-in-class noise immunity, low power consumption, and better immunity to magnetic fields. See the figure below for more details.

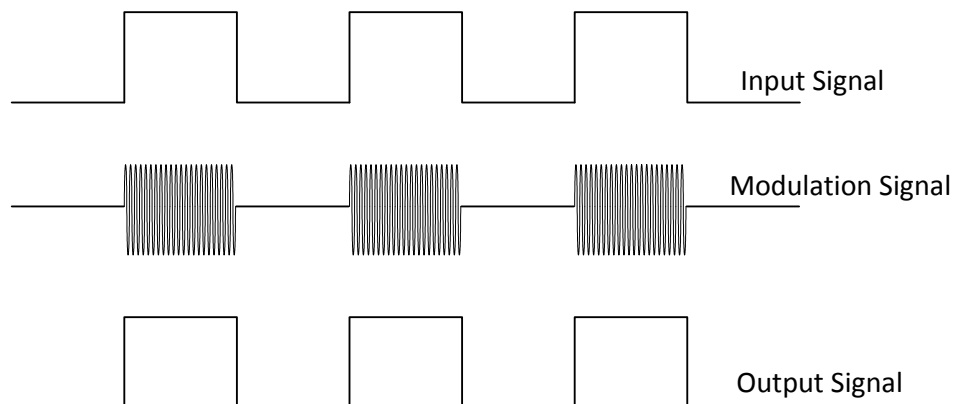


Figure 3.5. Modulation Scheme

### 3.3 Typical Operating Characteristics (0.5 Amp)

The typical performance characteristics depicted in [Figure 3.6 Rise/Fall Time vs. Supply Voltage](#) on page 11 through [Figure 3.15 Output Source Current vs. Temperature](#) on page 12 are for information purposes only. Refer to [Table 4.1 Electrical Characteristics<sup>1</sup>](#) on page 25 for actual specification limits.

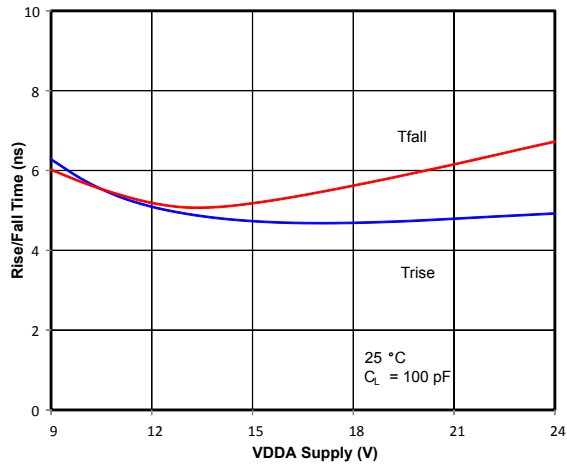


Figure 3.6. Rise/Fall Time vs. Supply Voltage

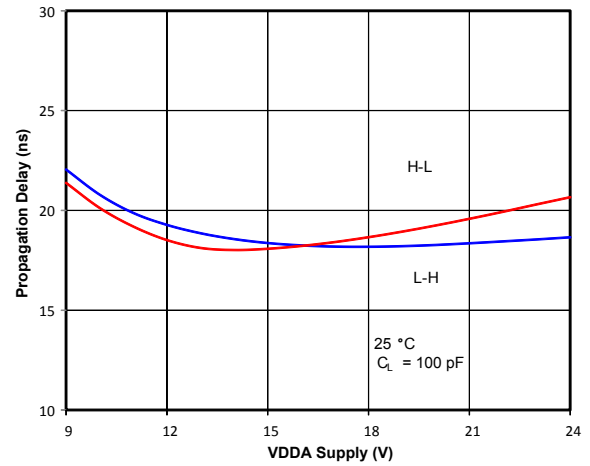


Figure 3.7. Propagation Delay vs. Supply Voltage

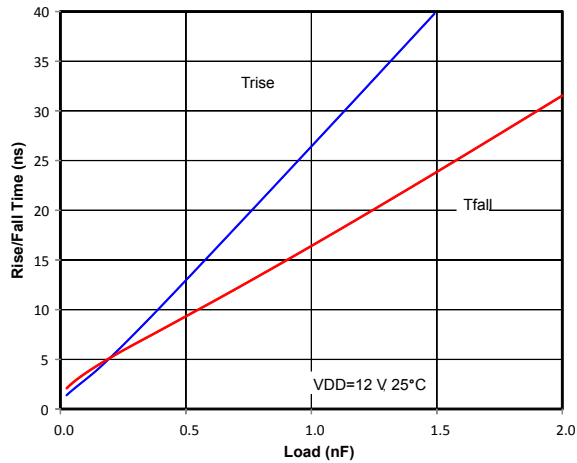


Figure 3.8. Rise/Fall Time vs. Load

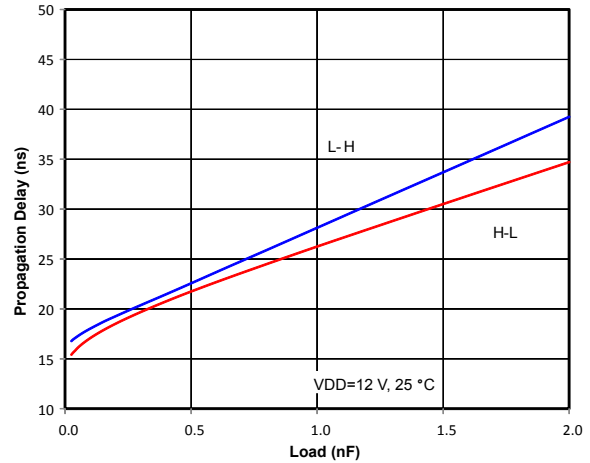


Figure 3.9. Propagation Delay vs. Load

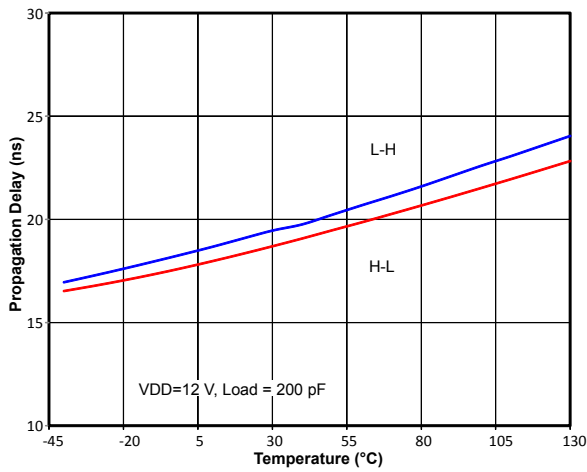


Figure 3.10. Propagation Delay vs. Temperature

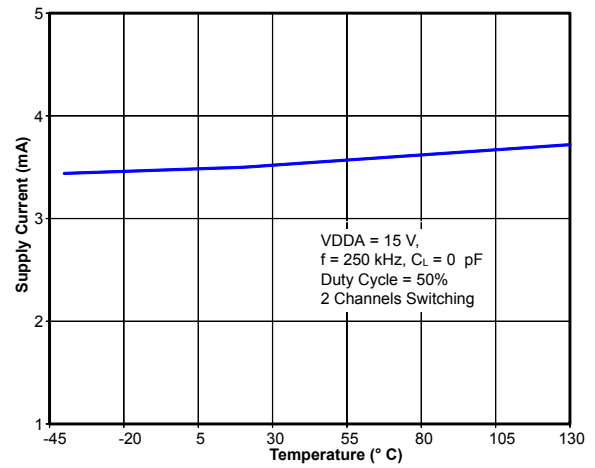


Figure 3.11. Supply Current vs. Temperature

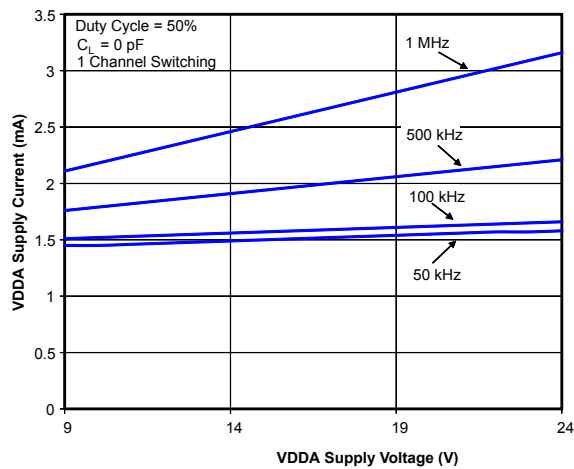


Figure 3.12. Supply Current vs. Supply Voltage

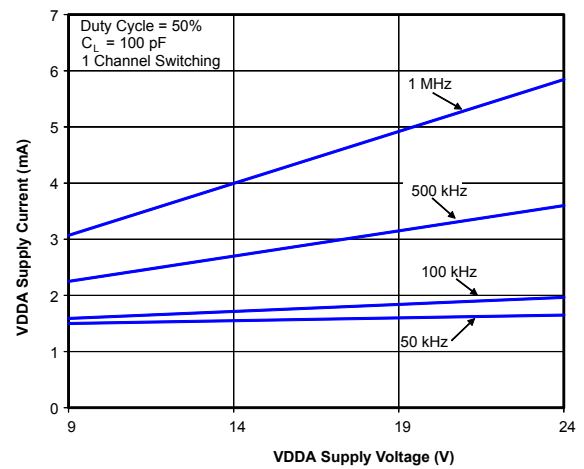


Figure 3.13. Supply Current vs. Supply Voltage

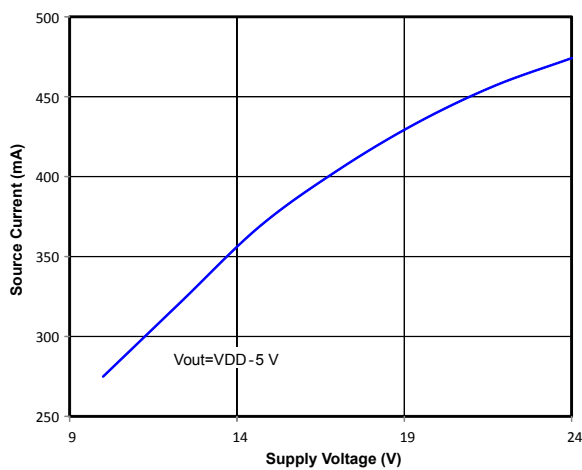


Figure 3.14. Output Source Current vs. Supply Voltage

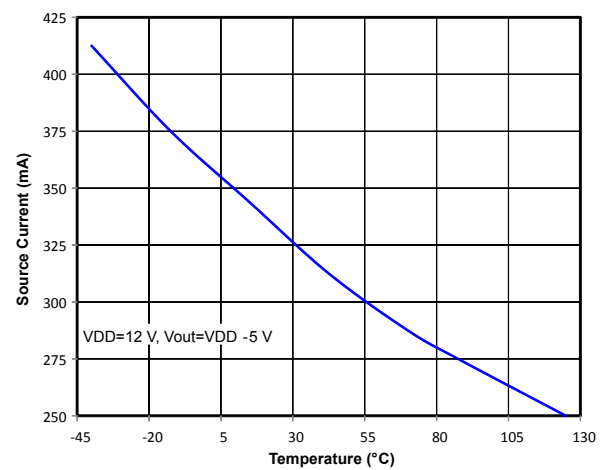


Figure 3.15. Output Source Current vs. Temperature

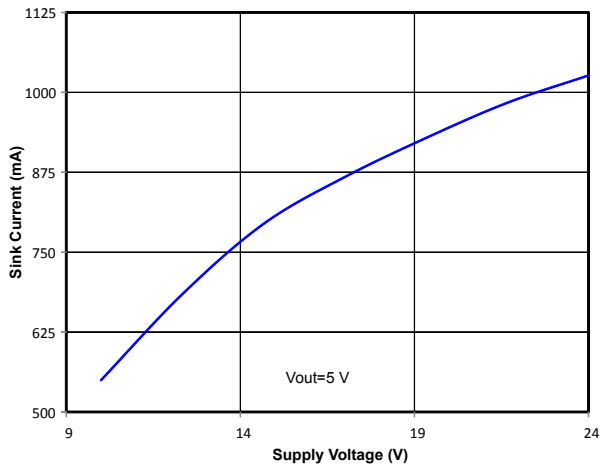


Figure 3.16. Output Sink Current vs. Supply Voltage

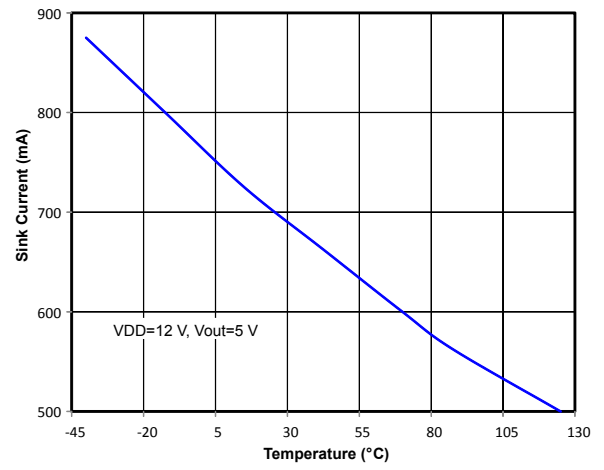


Figure 3.17. Output Sink Current vs. Temperature

### 3.4 Typical Operating Characteristics (4.0 Amp)

The typical performance characteristics depicted in Figure 3.18 Rise/Fall Time vs. Supply Voltage on page 14 through Figure 3.27 Output Source Current vs. Temperature on page 15 are for information purposes only. Refer to Table 4.1 Electrical Characteristics<sup>1</sup> on page 25 for actual specification limits.

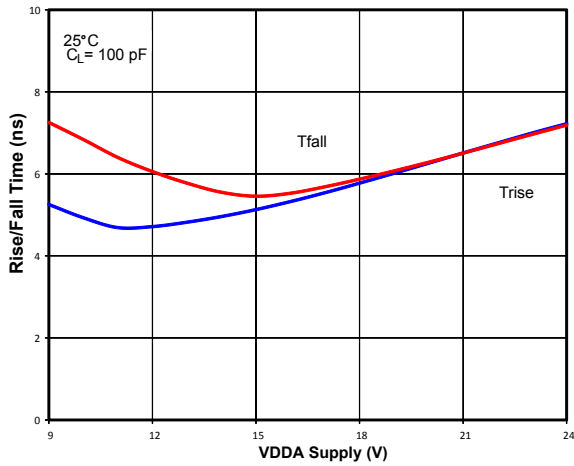


Figure 3.18. Rise/Fall Time vs. Supply Voltage

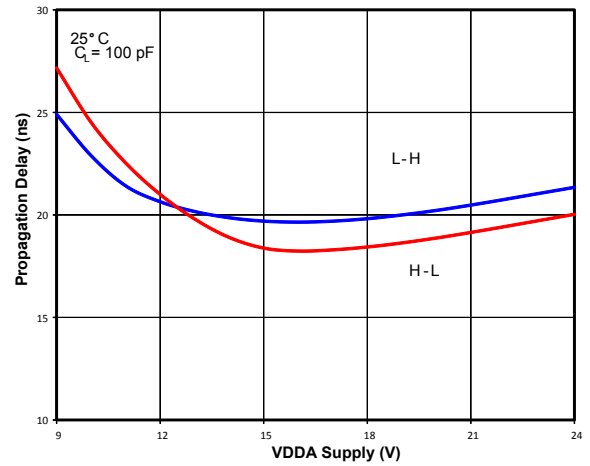


Figure 3.19. Propagation Delay vs. Supply Voltage

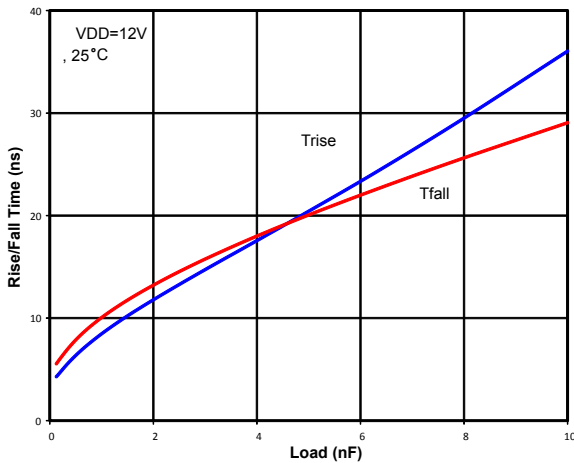


Figure 3.20. Rise/Fall Time vs. Load

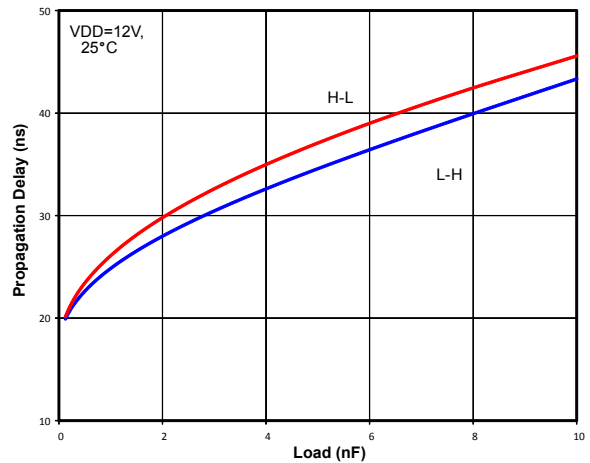


Figure 3.21. Propagation Delay vs. Load

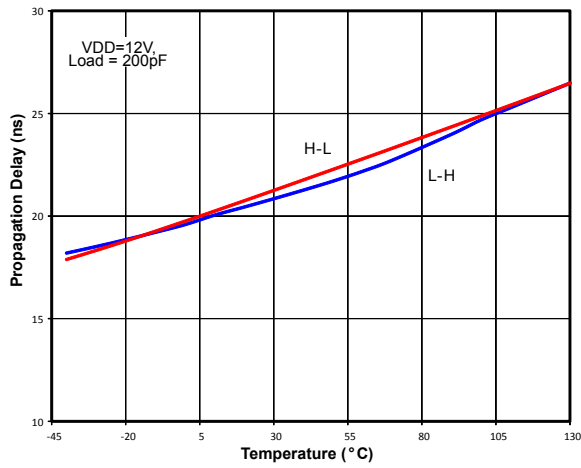


Figure 3.22. Propagation Delay vs. Temperature

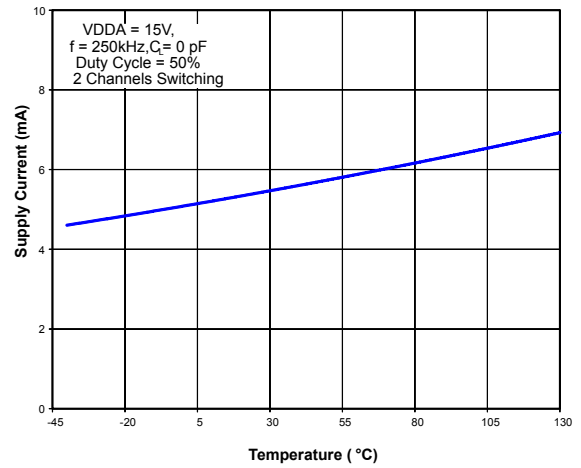


Figure 3.23. Supply Current vs. Temperature

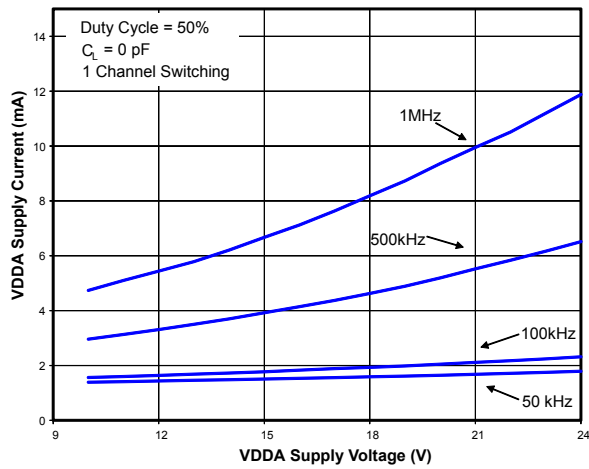


Figure 3.24. Supply Current vs. Supply Voltage

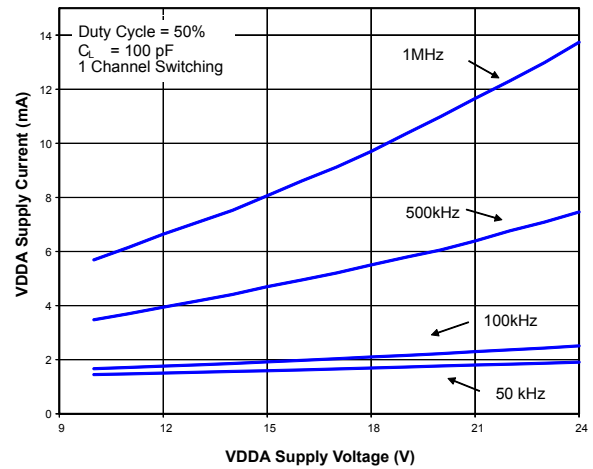


Figure 3.25. Supply Current vs. Supply Voltage

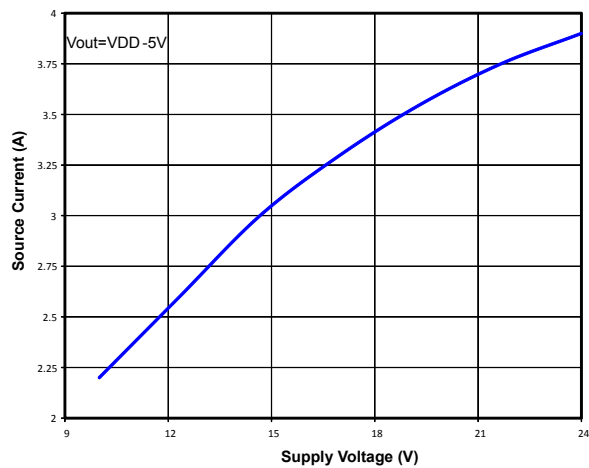


Figure 3.26. Output Source Current vs. Supply Voltage

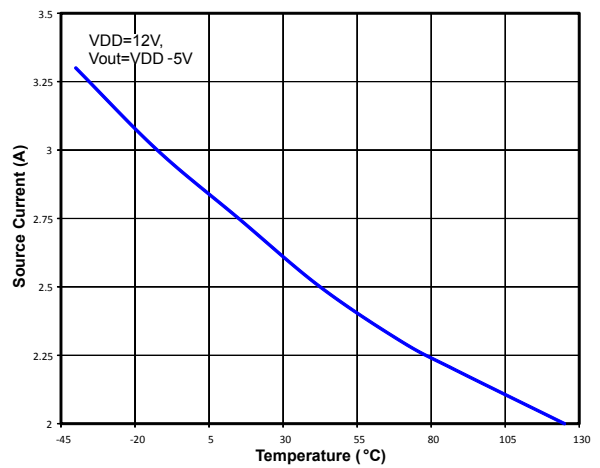


Figure 3.27. Output Source Current vs. Temperature



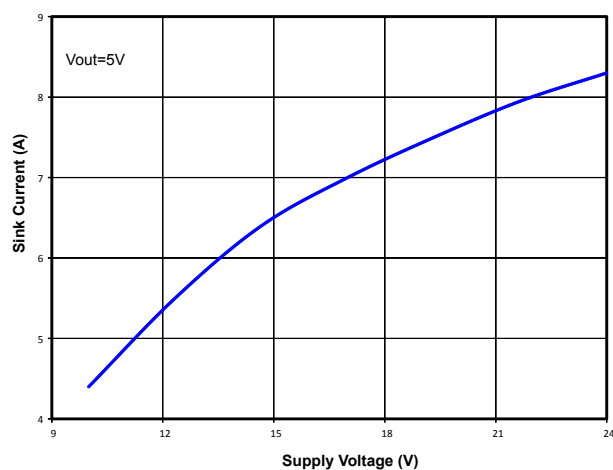


Figure 3.28. Output Sink Current vs. Supply Voltage

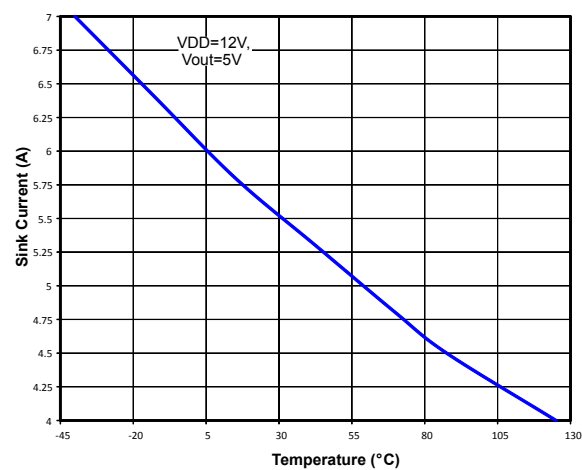


Figure 3.29. Output Sink Current vs. Temperature

### 3.5 Family Overview and Logic Operation During Startup

The Si823x family of isolated drivers consists of high-side, low-side, and dual driver configurations.

#### 3.5.1 Products

The table below shows the configuration and functional overview for each product in this family.

**Table 3.1. Si823x Family Overview**

Part Number	Configuration	Overlap Protection	Programmable Dead Time	Inputs	Peak Output Current (A)
Si8230	High-Side/Low-Side	√	√	VIA, VIB	0.5
Si8231	High-Side/Low-Side	√	√	PWM	0.5
Si8232/7	Dual Driver	—	—	VIA, VIB	0.5
Si8233	High-Side/Low-Side	√	√	VIA, VIB	4.0
Si8234	High-Side/Low-Side	√	√	PWM	4.0
Si8235/8	Dual Driver	—	—	VIA, VIB	4.0

## 3.5.2 Device Behavior

The table below consists of truth tables for the Si8230/3, Si8231/4, and Si8232/5/7/8 families.

Table 3.2. Si823x Family Truth Table<sup>1</sup>

Si8230/3 (High-Side/Low-Side) Truth Table						
Inputs		VDDI State	Disable	Output		Notes
VIA	VIB			VOA	VOB	
L	L	Powered	L	L	L	Output transition occurs after internal dead time expires.
L	H	Powered	L	L	H	Output transition occurs after internal dead time expires.
H	L	Powered	L	H	L	Output transition occurs after internal dead time expires.
H	H	Powered	L	L	L	Invalid state. Output transition occurs after internal dead time expires.
X <sup>2</sup>	X <sup>2</sup>	Unpowered	X	L	L	Output returns to input state within 7 μs of VDDI power restoration.
X	X	Powered	H	L	L	Device is disabled.
Si8231/4 (PWM Input High-Side/Low-Side) Truth Table						
PWM Input		VDDI State	Disable	Output		Notes
				VOA	VOB	
H		Powered	L	H	L	Output transition occurs after internal dead time expires.
L		Powered	L	L	H	Output transition occurs after internal dead time expires.
X <sup>2</sup>		Unpowered	X	L	L	Output returns to input state within 7 μs of VDDI power restoration.
X		Powered	H	L	L	Device is disabled.
Si8232/5/7/8 (Dual Driver) Truth Table						
Inputs		VDDI State	Disable	Output		Notes
VIA	VIB			VOA	VOB	
L	L	Powered	L	L	L	Output transition occurs immediately (no internal dead time).
L	H	Powered	L	L	H	Output transition occurs immediately (no internal dead time).
H	L	Powered	L	H	L	Output transition occurs immediately (no internal dead time).
H	H	Powered	L	H	H	Output transition occurs immediately (no internal dead time).
X <sup>2</sup>	X <sup>2</sup>	Unpowered	X	L	L	Output returns to input state within 7 μs of VDDI power restoration.
X	X	Powered	H	L	L	Device is disabled.
<b>Notes:</b>						
1. This truth table assumes VDDA and VDDB are powered. If VDDA and VDDB are below UVLO, see <a href="#">3.9 Undervoltage Lockout Operation</a> for more information.						
2. Note that an input can power the input die through an internal diode if its source has adequate current.						

### 3.6 Power Supply Connections

Isolation requirements mandate individual supplies for VDDI, VDDA, and VDDB. The decoupling caps for these supplies must be placed as close to the VDD and GND pins of the Si823x as possible. The optimum values for these capacitors depend on load current and the distance between the chip and the regulator that powers it. Low effective series resistance (ESR) capacitors, such as Tantalum, are recommended.

### 3.7 Power Dissipation Considerations

Proper system design must assure that the Si823x operates within safe thermal limits across the entire load range. The Si823x total power dissipation is the sum of the power dissipated by bias supply current, internal parasitic switching losses, and power dissipated by the series gate resistor and load. Equation 1 shows total Si823x power dissipation.

$$P_D = (V_{DD1})(I_{DD1}) + 2(I_{DD2})(V_{DD2}) + \left(f\right)\left(Q_{TL}\right)\left(V_{DD2}\right)\left[\frac{R_p}{R_p + R_g}\right] + \left(f\right)\left(Q_{TL}\right)\left(V_{DD2}\right)\left[\frac{R_p}{R_p + R_g}\right] + 2fC_{int}V_{DD2}^2$$

where:

$P_D$  is the total Si823x device power dissipation (W)

$I_{DD1}$  is the input-side maximum bias current (3 mA)

$I_{DD2}$  is the driver die maximum bias current (2.5 mA)

$C_{int}$  is the internal parasitic capacitance (75 pF for the 0.5 A driver and 370 pF for the 4.0 A driver)

$V_{DD1}$  is the input-side VDD supply voltage (2.7 to 5.5 V)

$V_{DD2}$  is the driver-side supply voltage (10 to 24 V)

$f$  is the switching frequency (Hz)

$Q_{TL}$  is the gate charge of the FET being driven

$R_G$  is the external gate resistor

$R_p$  is the  $R_{DS(ON)}$  of the driver pull-up switch: ( $R_p = 15 \Omega$  for the 0.5 A driver;  $R_p = 2.7 \Omega$  for the 4.0 A driver)

$R_n$  is the  $R_{DS(ON)}$  of the driver pull-down switch: ( $R_n = 5 \Omega$  for the 0.5 A driver and  $1 \Omega$  for the 4.0 A driver)

#### Equation 1

Power dissipation example for 0.5 A driver using Equation 1 with the following givens:

$$V_{DD1} = 5.0 \text{ V}$$

$$V_{DD2} = 12 \text{ V}$$

$$f = 350 \text{ kHz}$$

$$R_G = 22 \Omega$$

$$Q_{TL} = 25 \text{ nC}$$

$$P_d = 0.015 + 0.060 + \left(350 \times 10^3\right)\left(25 \times 10^{-9}\right)\left(12\right)\left[\frac{5}{5 + 22}\right] + 2\left[\left(350 \times 10^3\right)\left(75 \times 10^{-12}\right)\left(144\right)\right] = 145 \text{ mW}$$

From which the driver junction temperature is calculated using Equation 2, where:

$P_d$  is the total Si823x device power dissipation (W)

$\theta_{ja}$  is the thermal resistance from junction to air (105 °C/W in this example)

$T_A$  is the ambient temperature

$$T_j = P_d \times \theta_{ja} \times T_A = (0.145)(105) + 20 = 35.2^\circ\text{C}$$

The maximum power dissipation allowable for the Si823x is a function of the package thermal resistance, ambient temperature, and maximum allowable junction temperature, as shown in Equation 2:

$$P_{Dmax} \leq \frac{T_{jmax} - T_A}{\theta_{ja}}$$

where:

$P_{Dmax}$  = Maximum Si823x power dissipation (W)

$T_{jmax}$  = Si823x maximum junction temperature (150 °C)

$T_A$  = Ambient temperature (°C)

$\theta_{ja}$  = Si823x junction-to-air thermal resistance (105 °C/W)

$f$  = Si823x switching frequency (Hz)

### Equation 2

Substituting values for  $P_{Dmax}$ ,  $T_{jmax}$ ,  $T_A$ , and  $\theta_{ja}$  into Equation 2 results in a maximum allowable total power dissipation of 1.19 W. Maximum allowable load is found by substituting this limit and the appropriate data sheet values from [Table 4.1 Electrical Characteristics<sup>1</sup>](#) on page 25 into Equation 1 and simplifying. The result is Equation 3 (0.5 A driver) and Equation 4 (4.0 A driver), both of which assume  $V_{DDI} = 5\text{ V}$  and  $V_{DDA} = V_{VDD} = 18\text{ V}$ .

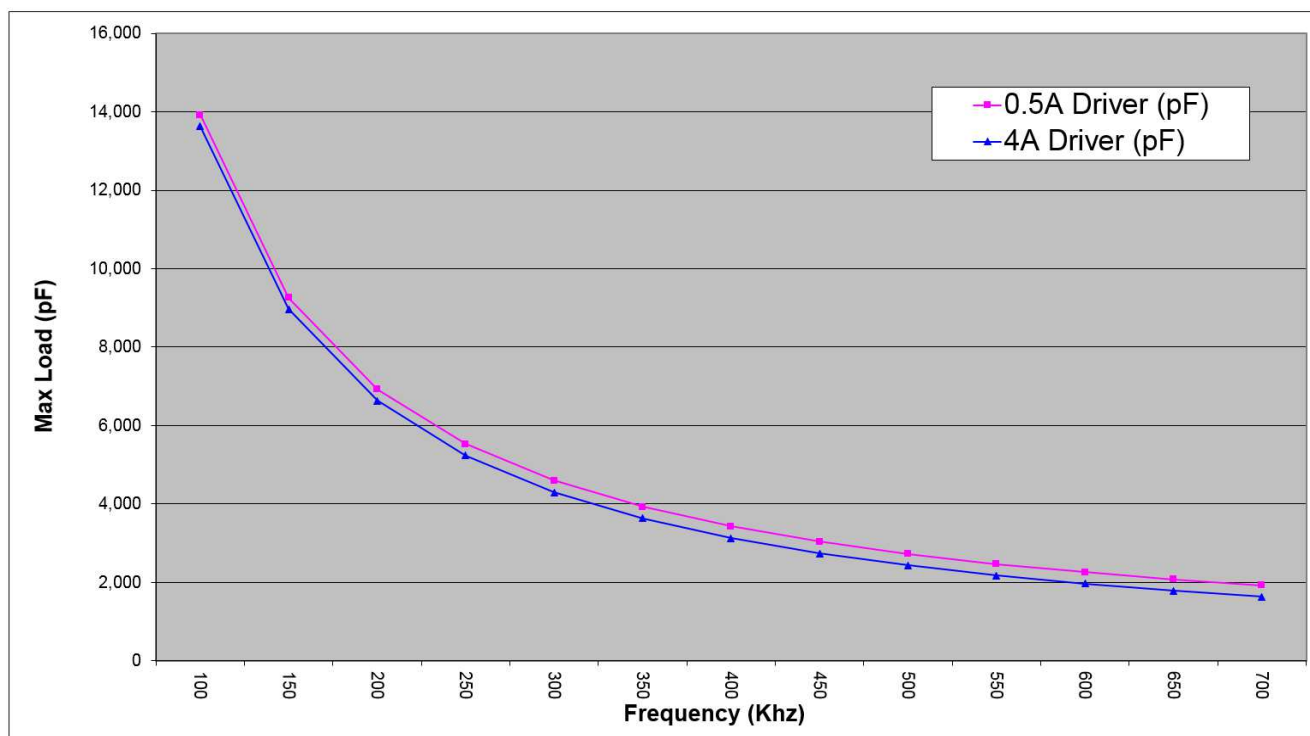
$$C_{L(MAX)} = \frac{1.4 \times 10^{-3}}{f} - 7.5 \times 10^{-11}$$

### Equation 3

$$C_{L(MAX)} = \frac{1.4 \times 10^{-3}}{f} - 3.7 \times 10^{-10}$$

### Equation 4

Equation 3 and Equation 4 are graphed in the figure below, where the points along the load line represent the package dissipation-limited value of CL for the corresponding switching frequency.



### 3.8 Layout Considerations

It is most important to minimize ringing in the drive path and noise on the Si823x VDD lines. Care must be taken to minimize parasitic inductance in these paths by locating the Si823x as close to the device it is driving as possible. In addition, the VDD supply and ground trace paths must be kept short. For this reason, the use of power and ground planes is highly recommended. A split ground plane system having separate ground and VDD planes for power devices and small signal components provides the best overall noise performance.

### 3.9 Undervoltage Lockout Operation

Device behavior during start-up, normal operation and shutdown is shown in [Figure 3.30 Device Behavior during Normal Operation and Shutdown on page 21](#), where UVLO+ and UVLO- are the positive-going and negative-going thresholds respectively. Note that outputs VOA and VOB default low when input side power supply (VDDI) is not present.

#### 3.9.1 Device Startup

Outputs VOA and VOB are held low during power-up until VDD is above the UVLO threshold for time period  $t_{START}$ . Following this, the outputs follow the states of inputs VIA and VIB.

#### 3.9.2 Undervoltage Lockout

Undervoltage Lockout (UVLO) is provided to prevent erroneous operation during device startup and shutdown or when VDD is below its specified operating circuits range. The input (control) side, Driver A and Driver B, each have their own undervoltage lockout monitors.

The Si823x input side enters UVLO when  $VDDI \leq VDDI_{UV-}$ , and exits UVLO when  $VDDI > VDDI_{UV+}$ . The driver outputs, VOA and VOB, remain low when the input side of the Si823x is in UVLO and their respective VDD supply (VDDA, Vddb) is within tolerance. Each driver output can enter or exit UVLO independently. For example, VOA unconditionally enters UVLO when VDDA falls below  $VDDA_{UV-}$  and exits UVLO when VDDA rises above  $VDDA_{UV+}$ .

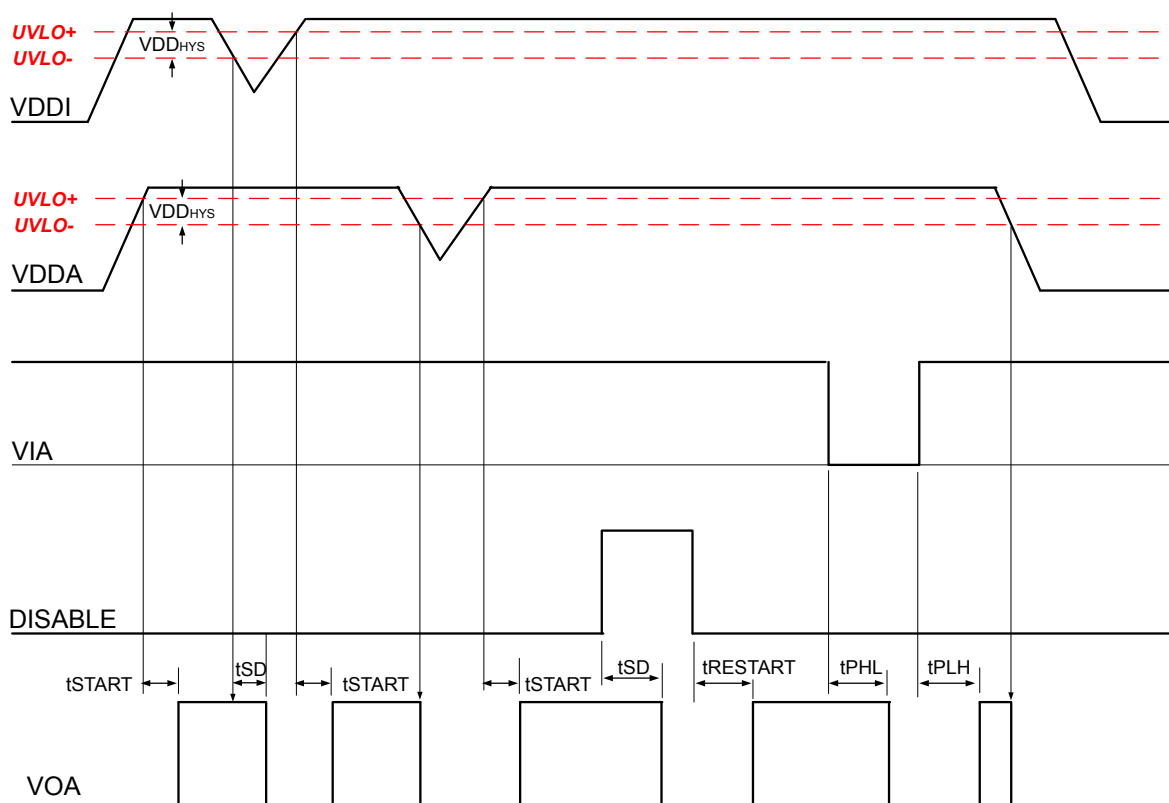


Figure 3.30. Device Behavior during Normal Operation and Shutdown

#### 3.9.3 Undervoltage Lockout (UVLO)

The UVLO circuit unconditionally drives VO low when VDD is below the lockout threshold. Upon power up, the Si823x is maintained in UVLO until VDD rises above  $VDD_{UV+}$ . During power down, the Si823x enters UVLO when VDD falls below the UVLO threshold plus hysteresis (i.e.,  $VDD \leq VDD_{UV+} - VDD_{HYS}$ ).

### 3.9.4 Control Inputs

VIA, VIB, and PWM inputs are high-true, TTL level-compatible logic inputs. A logic high signal on VIA or VIB causes the corresponding output to go high. For PWM input versions (Si8231/4), VOA is high and VOB is low when the PWM input is high, and VOA is low and VOB is high when the PWM input is low.

### 3.9.5 Disable Input

When brought high, the DISABLE input unconditionally drives VOA and VOB low regardless of the states of VIA and VIB. Device operation terminates within  $t_{SD}$  after  $DISABLE = V_{IH}$  and resumes within  $t_{RESTART}$  after  $DISABLE = V_{IL}$ . The DISABLE input has no effect if VDDI is below its UVLO level (i.e., VOA, VOB remain low).

### 3.10 Programmable Dead Time and Overlap Protection

All high-side/low-side drivers (Si8230/1/3/4) include programmable overlap protection to prevent outputs VOA and VOB from being high at the same time. These devices also include programmable dead time, which adds a user-programmable delay between transitions of VOA and VOB. When enabled, dead time is present on all transitions, even after overlap recovery. The amount of dead time delay (DT) is programmed by a single resistor (RDT) connected from the DT input to ground per Equation 5. Note that the dead time pin can be tied to VDD1 or left floating to provide a nominal dead time at approximately 400 ps.

$$DT \approx 10 \times RDT$$

where:

DT = dead time (ns) and

RDT = dead time programming resistor (k $\Omega$ )

#### Equation 5

The device driving VIA and VIB should provide a minimum dead time of TDD to avoid activating overlap protection. Input/output timing waveforms for the two-input drivers are shown in [Figure 3.31 Input / Output Waveforms for High-Side / Low-Side Two-Input Drivers on page 23](#), and dead time waveforms are shown in [Figure 3.32 Dead Time Waveforms for High-Side / Low-Side Two-input Drivers on page 24](#).

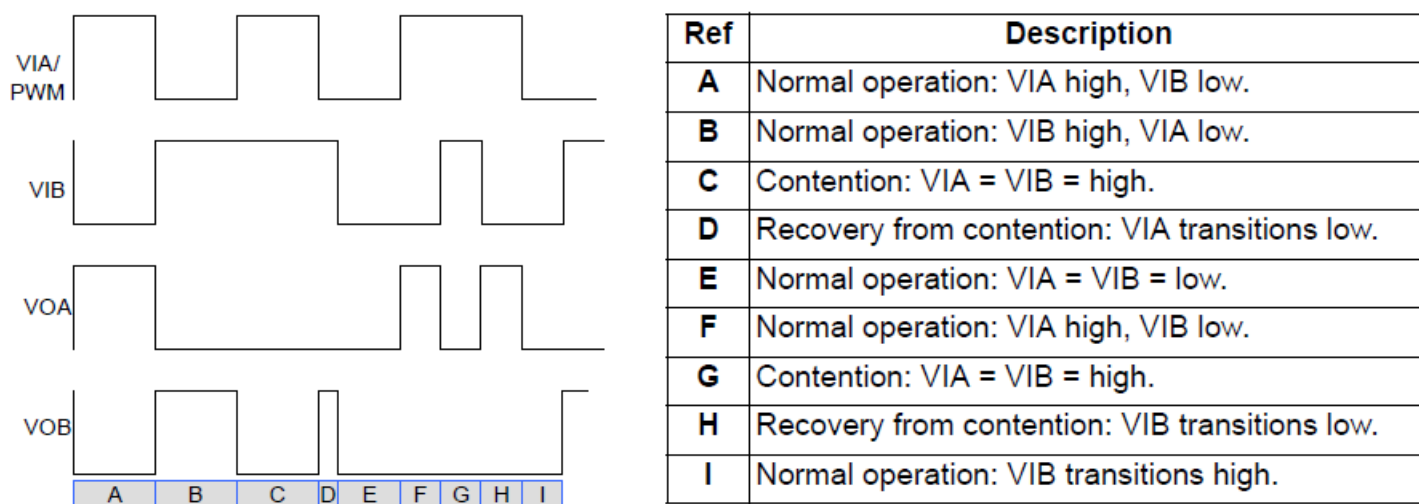
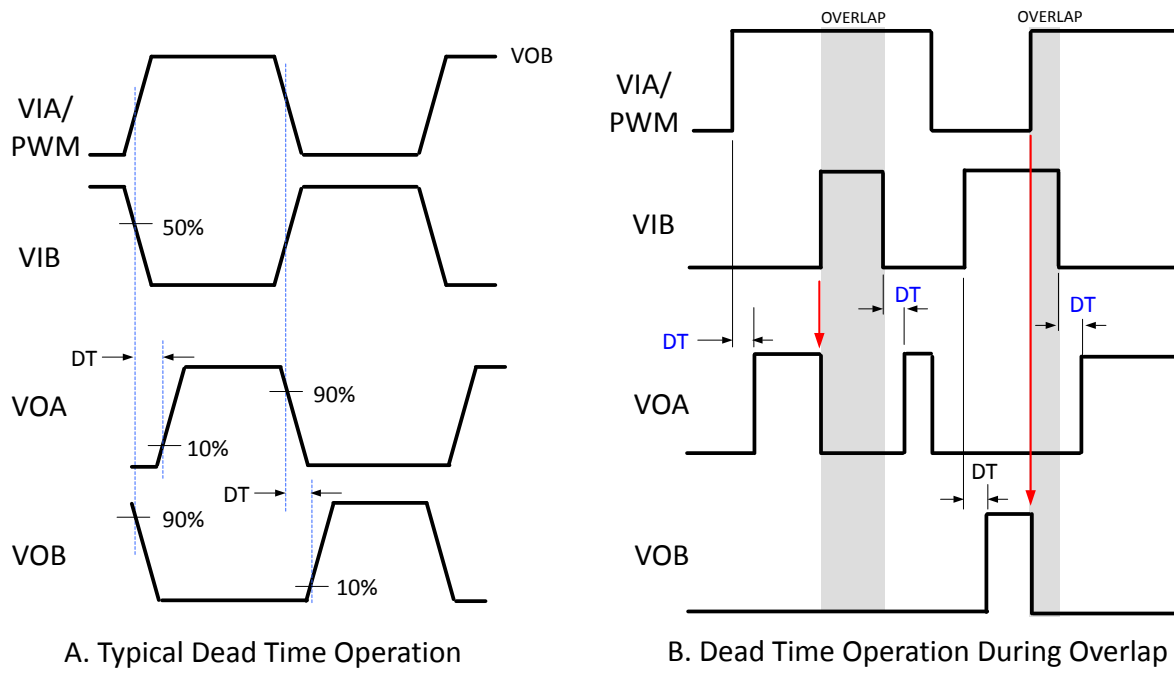


Figure 3.31. Input / Output Waveforms for High-Side / Low-Side Two-Input Drivers





**Figure 3.32. Dead Time Waveforms for High-Side / Low-Side Two-input Drivers**

## 4. Electrical Specifications

**Table 4.1. Electrical Characteristics<sup>1</sup>**

2.7 V < VDDI < 5.5 V, VDDA = VDDB = 12 V or 15 V, TA = -40 to +125 °C, Typical specs at 25 °C, T<sub>J</sub> = -40 to +150 °C

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>DC Specifications</b>						
Input-side Power Supply Voltage	VDDI	Si8230/1/2/3/4/5	4.5	—	5.5	V
		Si8237/8	2.7	—	5.5	
Driver Supply Voltage	VDDA, VDDB	Voltage between VDDA and GNDA, and VDDB and GNDB (See 2. Ordering Guide)	6.5	—	24	V
Input Supply Quiescent Current	IDDI(Q)	Si8230/2/3/5/7/8	—	2	3	mA
		Si8231/4	—	3.5	5	mA
Output Supply Quiescent Current	IDDA(Q), IDDB(Q)	Current per channel	—	—	3.0	mA
Input Supply Active Current	IDDI	Input freq = 500 kHz, no load	—	3.5	—	mA
Output Supply Active Current	IDDA	Current per channel with Input freq = 500 kHz, no load	—	6	—	mA
	IDDB					
Input Pin Leakage Current	IVIA, IVIB, IPWM		-10	—	+10	μA dc
Input Pin Leakage Current (Si8230/1/2/3/4/5)	IDISABLE		-10	—	+10	μA dc
Input Pin Leakage Current (Si8237/8)			-1000	+1000		
Logic High Input Threshold	VIH		2.0	—	—	V
Logic Low Input Threshold	VIL		—	—	0.8	V
Input Hysteresis	V <sub>IHYST</sub>	Si8230/1/2/3/4/5/7/8	400	450	—	mV
Logic High Output Voltage	VOAH, VOBH	IOA, IOB = -1 mA	(VDDA / VDDB) - 0.04	—	—	V
Logic Low Output Voltage	VOAL, VOBL	IOA, IOB = 1 mA	—	—	0.04	V
Output Short-Circuit Pulsed Sink Current	IOA(SCL), IOB(SCL)	Si8230/1/2/7, Figure 4.1 IOL Sink Current Test Circuit on page 28	—	0.5	—	A
		Si8233/4/5/8, Figure 4.1 IOL Sink Current Test Circuit on page 28	—	4.0	—	A
Output Short-Circuit Pulsed Source Current	IOA(SCH), IOB(SCH)	Si8230/1/2/7, Figure 4.2 IOH Source Current Test Circuit on page 28	—	0.25	—	A
		Si8233/4/5/8, Figure 4.2 IOH Source Current Test Circuit on page 28	—	2.0	—	A